Notice of References Cited Application/Control No. 10/766,792 Examiner Jessica L. Reidel Applicant(s)/Patent Under Reexamination SIGG ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | Α | US-5,282,844 | 02-1994 | Stokes et al. | 607/120 |
| * | В | US-6,287,285 | 09-2001 | Michal et al. | 604/264 |
| * | C | US-5,650,447 | 07-1997 | Keefer et al. | 514/772.4 |
| * | ם | US-5,496,359 | 03-1996 | Davidson, James A. | 607/115 |
| * | Е | US-5,681,278 | 10-1997 | Igo et al. | 604/507 |
| * | F | US-4,919,891 | 04-1990 | Yafuso et al. | 422/58 |
| | G | US- | | | |
| | Ξ | US- | | | |
| | - | US- | | | |
| | 7 | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | Z | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| _ | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | ٧ | |
| | w | - |
| | x | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.